

Search Notes

Application/Control No.

10/765,633

Examiner

David E. Bochna

Applicant(s)/Patent under
Reexamination

POLLOCK ET AL.

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner
285	369		
	374		
	404		
	330		
	93		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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INTERFERENCE SEARCHED

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